



<p>Searched</p> 	<p>Application/Control No.</p> <p>10705591</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LEE ET AL.</p>
	<p>Examiner</p> <p>Han, Jason M</p>	<p>Art Unit</p> <p>2875</p>

Class	SubClass	Date	Examiner
362	600, 606, 623-629	5/25/2006	JMH
349	56, 61-62, 65, 70	5/25/0062	JMH

U.S. Patent and Trademark Office	Part of Paper No.: 20060525
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Notes	Date	Examiner
EAST - (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	05/25/2006	JMH

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